

## APPARATUS FOR RING-BACK CONSTRICTION

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### BACKGROUND OF THE INVENTION

#### 5      **Field of the Invention**

[0001]      The invention relates in general to an apparatus for the ring-back constriction, and more particularly to an apparatus for the ring-back constriction for a high-frequency low-swing transmission bus.

#### **Description of the Related Art**

10      [0002]      Computers today run at a much higher clock frequency, and thus consume more power. The high-frequency low-swing transmission bus in the computer becomes popular because the computer is faster and more power save. Gunning Transceiver Logic Plus (GTL+) bus is one of the high-frequency low-swing transmission buses. In  
15      a computer, GTL+ buses are used between CPU and the north bridge chipset as transmission buses. A GTL+ bus includes one transmission line with two termination resistors to a termination voltage of high level. If the impedance of the transmission line does not match with the termination resistor, a reflection occurs in the bus. A reflective wave superimposes with the original signal and accordingly affects the wave shape of the signal. This phenomenon is known as a ring-back effect. The termination

resistor reduces the ring-back effect and pulls high the voltage of the bus for stabilizing the signal.

[0003] The comparator compares the signal on the transmission line with a reference voltage and accordingly outputs a comparison signal. When the line signal is lower in magnitude than the reference voltage, the line signal is determined as low, and the comparator outputs a low-level comparison signal. When the line signal is higher in magnitude than the reference voltage, the line signal is determined as high, and the comparator outputs a high-level comparison signal. Accordingly, the correctness of the line signal received is ensured. However, if the output node of the transmission line is positioned at the end of the transmission line, a termination resistor is required to match the impedance of the transmission line. The termination resistor constricts the ring-back effect and can pull high the voltage of the transmission line.

[0004] Figure 1 is a diagram of a well-known apparatus for the ring-back constriction. The apparatus includes a termination resistor R and a comparator 102. The comparator 102 receives the signal  $V_i$  on the transmission line L of a GTL+ bus. The comparator 102 compares the line signal  $V_i$  with a reference voltage  $V_{ref}$  and outputs a comparison signal  $V_c$ . The comparison signal  $V_c$  determines the line signal  $V_i$  to be at either high or low level. In the figure, the voltage  $V_{tt}$  is the termination voltage of the GTL+ bus. Generally, the voltage  $V_{tt}$  is 1.5 volt, and the reference voltage is 1 volt.

[0005] When the line signal  $V_i$  is high, the voltage difference between the two ends

of the termination resistor R is almost zero, and thus the termination resistor R consumed almost no power. When the line signal  $V_i$  transits from high to low, the ring-back effect can be constricted due to the impedance match between the termination resistor end and the transmission line L. However, a current flows through the termination resistor R when the line signal  $V_i$  is low, and the power consumption increases. In addition, each transmission line of the GTL+ bus needs termination resistors outside the chipset and thus the cost is increased.

[0006] Figure 2 is another well-known apparatus for the ring-back constriction. The apparatus uses variable resistors as termination resistors. The advantage is that the power consumption is reduced. That is because when the line signal is low, the resistance of the variable resistor is turned to extremely high. The apparatus includes a termination controller 202, a termination variable resistor  $R_t$ , and a comparator 203. When the line signal  $V_i$  is high, the resistance of the termination variable resistor  $R_t$  becomes low according to the termination control signal  $S_t$  generated by the termination controller 202. The ring-back effect is thus constricted due to the impedance match. The signal on the transmission line L is also stabilized because the voltage of the transmission line L is pulled high by the voltage  $V_{tt}$  through the termination variable resistor  $R_t$ . In addition, almost no power is consumed at the termination variable resistor  $R_t$  because the voltage difference at the two ends of the termination variable resistor  $R_t$  is almost zero. When the line signal  $V_i$  is low, the resistance of the termination variable resistor  $R_t$  becomes high according to the termination control signal  $S_t$  generated by the termination controller 202. Also, almost no power is consumed at the termination variable resistor  $R_t$  because the resistance of

the termination variable resistor  $R_t$  is high. The termination variable resistor  $R_t$  is implemented by a transistor, and the apparatus is included in the chipset.

[0007] However, in this prior art, the impedance match is not good enough if the termination variable resistor  $R_t$  does not have a good linear I-V curve. The line signal  $V_i$  undershoot and accordingly a ring-back occurs. Detailed description about the effects of the ring-back constriction using fixed resistors (as in Fig. 1) and variable resistors (as in Fig. 2) will be discussed in the following paragraph.

[0008] Figure 3A is the transition diagram of the line signal  $V_i$  stated in Fig. 1. As shown, when the line signal  $V_i$  transits, the ring-back effect can be efficiently constricted. In the figure, the bit time  $t_b$  is the time needed to transfer a bit. Figure 3B is the transition diagram of the line signal  $V_i$  stated in Fig. 2. The ring-back constriction is not as good as that shown in Fig. 3A because the termination variable resistor  $R_t$  is implemented by a transistor in integrated circuits; while the resistor shown in Fig. 1 is a common resistor. The node A is an undershooting point, and the node B is a ring-back point. If the voltage difference between the ring-back value at node B and the reference voltage  $V_{ref}$  is less than 0.2 volt, the reading of the line signal will possibly be wrong. When the working frequency of the GTL+ bus is 100MHz, the apparatus shown in Fig. 2 can work normally without errors. However, when the working clock frequency of the GTL+ bus is higher, such as 133MHz, ring-back effects become more obvious and thus reading errors occur.

## SUMMARY OF THE INVENTION

[0009] It is therefore an object of the invention to provide an apparatus for better ring-back constriction.

5 [00010] The invention achieves the above-identified objects by providing a new apparatus for the ring-back constriction. The apparatus couples to a transmission line, for constricting the ring-back effect. The apparatus includes a comparator, a termination controller, a termination variable resistor, a constriction controller, and a constriction variable resistor. The comparator couples to the transmission line, for comparing the line signal with a reference voltage, and accordingly outputting a comparison signal. The termination controller couples to the comparator, for outputting a termination control signal according to the comparison signal. The termination variable resistor couples to a termination voltage and the transmission line, and the resistance of the termination variable resistor is adjusted according to the termination control signal. The constriction controller couples to the comparator for outputting a constriction signal. The constriction variable resistor couples to a constriction voltage and the transmission line, and the resistance of the constriction variable resistor is adjusted according to the constriction signal for providing a constriction voltage to the transmission line.

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## BRIEF DESCRIPTION OF THE DRAWINGS

20 [00011] Other objects, features, and advantages of the invention will become apparent from the following detailed description of the preferred but non-limiting

embodiments. The description is made with reference to the accompanying drawings, in which:

[00012] Figure 1 is a diagram of a well-known apparatus for the ring-back constriction;

5 [00013] Figure 2 is another well-known apparatus for the ring-back constriction;

[00014] Figure 3A is the transition diagram of the line signal Vi stated in Fig. 1;

[00015] Figure 3B is the transition diagram of the line signal stated in Fig. 2;

[00016] Figure 4 is a preferred embodiment of an apparatus for the ring-back constriction according to this invention;

10 [00017] Figure 5 is an example of the embodiment shown in Fig. 4;

[00018] Figure 6 is the wave diagram of the line signal; and

[00019] Figure 7 is the wave diagram of the line signal after the ring-back constriction by this invention.

#### DESCRIPTION OF THE PREFERRED EMBODIMENT

15 [00020] The apparatus of ring-back constriction of this invention is used in a high-frequency low-swing bus, such as a GTL+ bus. In the following embodiment, the GTL+ bus is used as an example of the high-frequency low-swing bus to illustrate the

invention in detail.

[00021] Figure 4 is a preferred embodiment of an apparatus for the ring-back  
constriction according to this invention. The apparatus is coupled to a transmission line  
of the GTL+ bus, for constricting the ring-back effect of the line signal Vi. The  
5 apparatus includes a comparator 402, a termination variable resistor Rt, a termination  
controller 404, a constriction variable resistor Re, and a constriction controller 408.  
When the line signal Vi transits from the high level to the low level, the comparator  
402 outputs a comparison signal Vc to the termination controller 404. Accordingly the  
10 termination controller 404 outputs a termination control signal Ctrl1 to adjust the  
resistance of the termination variable resistor Rt to a high value. The high-value  
resistance of the termination variable resistor Rt blocks a current passing through the  
resistor Rt, which has been described above in detail. Note that when the line signal Vi  
transits from the high level to the low level, the line signal Vi has an undershoot  
because the impedance between the resistor Rt and the transmission line L does not  
15 match. The undershoot of the line signal Vi then causes a ring-back. In order to constrict  
the ring-back, the invention uses a higher voltage to pull the voltage of the  
transmission line L higher when the undershoot occurs, and then the ring-back can be  
constricted.

[00022] In the invention, one end of the constriction variable resistor Re is coupled  
20 to a constriction voltage Vh, and the other end of the constriction variable resistor Re  
is coupled to the transmission line L. The resistance of the resistor Re is determined  
according to the constriction control signal Ctrl2. The constriction controller 408

couples to the comparator 402 and the constriction variable resistor  $R_e$  for outputting the constriction control signal Ctrl2. Generally, the reference voltage is 1 volt, the terminal voltage is 1.5 volt, the constriction voltage  $V_h$  is higher than the terminal voltage  $V_{tt}$ , and the constriction voltage  $V_h$  is about 2.5 or 2.6 volt.

5 [00023] Figure 5 is an example of the embodiment shown in Fig. 4. The termination variable resistor  $R_t$  includes a PMOS transistor Q1. When the termination control signal Ctrl1 is high, the transistor Q1 is off; when the termination control signal Ctrl1 drops from the high level, the resistance of the transistor Q1 is accordingly smaller. The constriction variable resistor  $R_e$  includes a PMOS transistor Q2. When the constriction control signal Ctrl2 is high, the transistor Q2 is off; when the constriction control signal Ctrl2 drops from the high level, the resistance of the transistor Q2 is accordingly smaller. The termination controller 404 includes a PMOS transistor Q3, a NMOS transistor Q4, and a delay unit 504. The PMOS transistor Q3 and the NMOS transistor Q4 together are used as an inverter. The delay unit 504 delays the  
10 comparison signal  $V_c$  for a delay period  $t_1$ , and then outputs the delayed comparison signal  $V_c$  to the inverter of the termination controller 404. Then the inverter outputs the termination control signal Ctrl1 to the termination variable resistor  $R_t$ . The constriction controller includes a NAND gate 508, an inverter 510, and a delay unit 506. The delay unit 506 delays the comparison signal  $V_c$  for a delay period  $t_1$ . The  
15 inverter 510 inverts the comparison signal  $V_c$ . The NAND gate 508 receives the delayed comparison signal and the inverted comparison signal and accordingly generates a pulse. In the delay period  $t_1$ , the pulse is high, and accordingly the resistance of the constriction variable resistor  $R_e$  is low; after the delay period  $t_1$ , the  
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pulse is low, and accordingly the resistance of the constriction variable resistor  $R_e$  is high. The PMOS transistor Q3 is a weak transistor such that a transition period  $t_2$  is needed for the transistor Q3 to change the resistance of the termination variable resistor  $R_t$  from the low value to the high value. The NAND gate 508 includes a weak PMOS transistor, the weak PMOS transistor needs a transition period  $t_3$  to change the resistance of the constriction variable resistor  $R_e$  from the low value to the high value. These weak transistors prevent radical changes of the resistance, while radical changes may induce more reflections.

[00024] Figure 6 is the wave diagram of the line signal  $V_i$ , the constriction control signal Ctrl2, the resistance of the constriction variable resistor  $R_e$ , the termination control signal Ctrl1, and the resistance of the termination variable resistor  $R_t$ . When the line signal  $V_i$  is high, the resistance of the constriction variable resistor  $R_e$  is of a high value  $R_{eh}$ , and the resistance of the termination resistor  $R_t$  is of a low value  $R_{tl}$ . When the line signal  $V_i$  transits from the high level to the low level, the constriction controller 408 outputs the constriction control signal Ctrl2 in order to change the resistance of the constriction variable resistor  $R_e$  to the low value, and the transistor Q2 of the constriction variable resistor  $R_e$  and the transistor Q1 of the termination variable resistor  $R_t$  are turned on during period  $t_1$ . Because the constriction voltage  $V_h$  is larger than the termination voltage  $V_{tt}$ , the turn-on of the transistor Q2 of the constriction variable resistor  $R_e$  pulls the transmission line L to reduce the undershot and thus constricts the ring-back effect. After the delay period  $t_1$ , the constriction control ends.

[00025] When the constriction control is ended, the resistance of the constriction variable resistor  $R_e$  and the resistance of the termination variable resistor  $R_t$  should be slowly increased to avoid inducing reflective waves due to the dramatic change of the resistances. First, the voltage level of the constriction control signal  $Ctrl2$  raises and accordingly the resistance of the constriction variable resistor  $R_e$  increases. The voltage level of the termination control signal  $Ctrl1$  also rises and accordingly the resistance of the termination variable resistor  $R_t$  increases. After a transition period  $t_2$ , the voltage level of the termination control signal  $Ctrl1$  rises to the high level  $H$  to save power consumption. It takes a transition period  $t_3$  to raise the voltage level of the constriction voltage level to the high level, and accordingly the resistance of the constriction variable resistor  $R_e$  increases to the high value  $R_{eh}$ .

[00026] Figure 7 is the wave diagram of the line signal  $V_i$  after the ring-back constriction in this invention. The ring-back is effectively constricted. The properly turn-off of the variable resistors saves power consumption. And the apparatus by this invention can be implemented in the chipset to reduce the number of the resistors needed outside the chipset.

[00027] While the invention has been described by way of examples and in terms of a preferred embodiment, it is to be understood that the invention is not limited thereto. On the contrary, it is intended to cover various modifications and similar arrangements and procedures, and the scope of the appended claims therefore should be accorded the broadest interpretation so as to encompass all such modifications and similar arrangements and procedures.